

**Search Notes****Application/Control No.**

10/729,475

**Examiner**

TAEYOON KIM

**Applicant(s)/Patent under  
Reexamination**

PAKOLA ET AL.

**Art Unit**

1651

**SEARCHED**

Class	Subclass	Date	Examiner
424	94.64	12/3/2008	TK
424	94.1	12/3/2008	TK
604	290	12/3/2008	TK
424	94.6	12/3/2008	TK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
424	94.64	12/3/2008	TK
424	94.1	12/3/2008	TK
424	94.6	12/3/2008	TK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR